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FORM PTO-1449 (10-96 MODIFIED) LIST OF PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Substitution	te for for	m 1449/	√ PTO	Complete if Known			
RADE				Application Number	09/824,965		
INFOR			OSURE STATEMENT	Filing Date	April 3, 2001		
	BY APPLICANT			First Named Inventor	Tomohiro Kawase		
				Group Art Unit	1765		
	(use as m	any shee	ets as necessary)	Examiner Name	Robert Kunemund		
Sheet	1	of	1	Attorney Docket Number	11542/1		

	U.S. PATENT DOCUMENTS							
Examiner Initials*	Document Number	Date	Name of Patentee or Applicant	Class/SubClass	Filing Date (if appropriate)			

FOREIGN DOCUMENTS									
Examiner Initials	Document Number	Date	Country	Class/SubClass	Transl	ation			
				4	Yes	No			

	OTHER DOCUMENTS					
Examiner Initials	Document Number	Author, Title, Date, Pertinent Pages, Etc.				
RK	AV	H.D. Marshall & D.W. DeCuir; "A novel technique to reduce the concentration of carbon in LEC gallium arsenide"; pages 960 – 962 of Journal of Crystal Growth 110 (1991) North Holland.				

Examiner	/Robert Kunemund/	Date	10/04/2006
Signature	/ Robert Runemand/	Considered	10/04/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line though citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet <u>1</u> of <u>1</u>

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attoniey's Docket No. 12967-002001	Application No. 09/824,965	
1	closure Statement oplicant	Applicant Tonnohiro Kawase et al.		
(Use several si	heets if necessary)	Filing Date April 3, 2001	Group Art Unit 1765	

			U.S. Patent	Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						5
	AB						
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Foreign Patent Documents or Published Foreign Patent Applications								
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	AM							
	AN							
	AO							
-	AP							

	Other D	ocuments (include Author, Title, Date, and Place of Publication)
Examiner Initial	Desig. ID	Document
RK	AY	Letter, Charles W. Bradley to John B. Pegram, January 29, 2003 (I p.)
RK	AZ	Declaration of Hunter D. Marshall, undated (5 pp.)

Examiner Signature	Date Considered
/Robert Kunemund/	10/04/2006
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STA	STATEMENT BY APPLICANT			First Named Inventor	Kawase et al			
	Alex en mem she	-4	·	Art Unit	1765			
	(Use as marry sheets as necessary)			Examiner Name	Robert Kunemund			
Sheet	1	of	1	Attorney Docket Number	12967-002001			

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (In CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
	AC	Frank, Ch., et al., "Description of Facet Growth During BGF Growth," Cryst. Res. Technol., 29 (1994)1, pp. K12-16	
	AD	Frank C., et al., "Growth of Semiinsulating GaAs Crystsals by Vertical Graident Freez Technique," Cryst. Res. Technol., 30 (1995) 7, pp. 897-909.	
	AE	Bourret, E.D., et al., "Effects of Total Liquid Encapsulation on the Characteristics of GaAs Single Crystals Grown," J. Cryst. Gr. 11 (1991), pp. 395-404.	
	AF	Hein, K., et al. "Die Kristasllisation aus Schmelzen als metallurgischer ProzeB," Metall, 47, Jahrgang, Heft 10, October 1993.	
	AG	Flade, et al. "Etwicklung großflachiger GaAs-Substrate," Freiberger, June 20, 1995.	
	АН	Marshall et al., "A novel technique to reduce the concentration of Carbon in LEC gallium arsenide," J. Crys. Growth, 110 (1991), pp. 960-962.	
	D4	Dissertation of Christian Frank, 1995, Technische Universitat-Bergakademie Freiberg (D4A Catalogue Data re Publication Year) (Partial Translation)	1
	D5	Diploma paper Matthias Muller, Sept. 15, 1993, Universitat Erlangen- Numberg (D5A Letter re Publication Date) (Partial Translation)	1

Examiner Signature	Date Considered	1/2/105
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1 Applicant's unique citation designation number/(optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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Complete if Known Substitute for form 1449/PTO Application Number 09/824,965 Filing Date April 3, 2001 INFORMATION DISCLOSURE First Named Inventor Kawase et al. STATEMENT BY APPLICANT Art Unit 1765 (Use as many sheets as necessary) **Examiner Name** Robert Kunemund

Sheet	1	of 1		Attorney Docket Number	12967-002001
			11 0 000	A DOMINICATION	
				DOCUMENTS	
Examiner	Cite No.1	Document Number	Publication Date	Name of Patentee	
30	Number-Kind Code ^{2 (1 (100007)}	MM-DD-YYYY	Applicant of Cited Doc.	rment Relevant Passages or Relevan Figures Appear	
//0		^{US-} 5041186	08-20-1991	Nishio, et al.	
1		^{US-} 5400742	03-28-1995	Nishio, et al.	
1		^{US-} 5471945	12-05-1995	Nishio, et al.	
1		^{US-} 5387544	02-07-1995	Hayafuji	
		^{US-} 4478675	10-23-1984	Akai	
		^{US-} 5186784	02-16-1993	Rau et al.	
1		us- 5259916	11-09-1993	Rau et al.	
		US- 5415125	05-16-1995	Fujita et al.	
		^{US-} 4083748	04-11-1978	Gault	
		US- 4404172	09-13-1983	Gault	
<u> </u>		US- 4521272	06-04-1985	Gault	
		^{US-} 5342475	08-30-1994	Yoshida et al.	
		^{US-} 4946544	08-07-1990	Ejim	
		^{US-} 5256381	10-26-1993	Tada et al.	
		US- 5145550	09-08-1992	Tada et al.	
1		US- 4923561	05-08-1990	Chemans et al.	
		^{US-} 4678534	07-07-1987	Tada et al.	
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		FOREIG	N PATENT DOCL	IMENTS		
	Cite No.1	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages	
M		Country Code ³ "Number ⁴ " Kind Code ³ (If known)	MM-DD-YYYY		Or Relevant Figures Appear	Γ°
Ma	AA	64-37833	02-08-1989	Yamamoto et al.		1
· ///	AB	59-054699	03-29-1984	Kokubu et al.		
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